Search Notes

Application/Control N	o. Applicant(s)/Patent under Reexamination	Applicant(s)/Patent under Reexamination	
10/748,368	TYRRELL ET AL.		
Examiner	Art Unit		
Jeffrey R. Snay	1743		

SEARCHED				
Class	Subclass	Date	Examiner	
250	505.1 504R	6/25/2005	JRS	
422	82.05	6/25/2005	JRS	
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INTERFERENCE SEARCHED				
/Subclass	Date	Examiner		

(INCLUDING SEARCH STRATEGY)				
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